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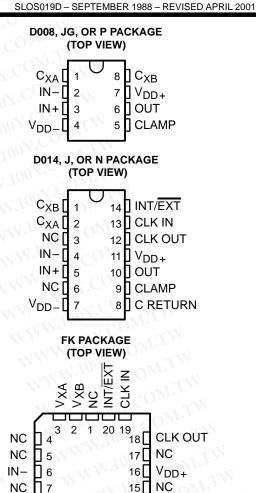
TLC2652, TLC2652A, TLC2652Y Advanced LinCMOS[™] PRECISION CHOPPER-STABILIZED OPERATIONAL AMPLIFIERS

- Extremely Low Offset Voltage ... 1 μV Max
- Extremely Low Change on Offset Voltage With Temperature ... 0.003 μV/°C Typ
- Low Input Offset Current 500 pA Max at T_A = - 55°C to 125°C
- A_{VD} . . . 135 dB Min
- CMRR . . . 120 dB Min
- k_{SVR} . . . 110 dB Min
- Single-Supply Operation
- Common-Mode Input Voltage Range Includes the Negative Rail
- No Noise Degradation With External Capacitors Connected to V_{DD}_

description

The TLC2652 and TLC2652A are high-precision chopper-stabilized operational amplifiers using Texas Instruments Advanced LinCMOS[™] process. This process, in conjunction with unique chopper-stabilization circuitry, produces opera tional amplifiers whose performance matches or exceeds that of similar devices available today.

Chopper-stabilization techniques make possible extremely high dc precision by continuously nulling input offset voltage even during variations in temperature, time, common-mode voltage, and power supply voltage. In addition, low-frequency noise voltage is significantly reduced. This high precision, coupled with the extremely high input impedance of the CMOS input stage, makes the TLC2652 and TLC2652A an ideal choice for low-level signal processing applications such as strain gauges, thermocouples, and other transducer amplifiers. For applications that require extremely low noise and higher usable bandwidth, use the TLC2654 or TLC2654A device, which has a chopping frequency of 10 kHz.



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No internal connection

RETURN CLAMP

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The TLC2652 and TLC2652A input common-mode range includes the negative rail, thereby providing superior performance in either single-supply or split-supply applications, even at power supply voltage levels as low as ± 1.9 V.

IN+ 🛛 8

NC

Two external capacitors are required for operation of the device; however, the on-chip chopper-control circuitry is transparent to the user. On devices in the 14-pin and 20-pin packages, the control circuitry is made accessible to allow the user the option of controlling the clock frequency with an external frequency source. In addition, the clock threshold level of the TLC2652 and TLC2652A requires no level shifting when used in the single-supply configuration with a normal CMOS or TTL clock input.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Advanced LinCMOS is a trademark of Texas Instruments.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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OUT

On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

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description (continued)

Innovative circuit techniques are used on the TLC2652 and TLC2652A to allow exceptionally fast overload recovery time. If desired, an output clamp pin is available to reduce the recovery time even further.

The device inputs and output are designed to withstand –100-mA surge currents without sustaining latch-up. Additionally the TLC2652 and TLC2652A incorporate internal ESD-protection circuits that prevent functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2; however, care should be exercised in handling these devices, as exposure to ESD may result in degradation of the device parametric performance.

The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from -40°C to 85°C. The Q-suffix devices are characterized for operation from -40°C to 125°C. The M-suffix devices are characterized for operation over the full military temperature range of -55°C to 125°C.

					ABLE OF HONO				
N	V.CU	W	WWW Y	P/	ACKAGED DEVICES	S WW	LOOX.C.	WTIE	
	Viomax	M	8 PIN	1.100	ONL.	14 PIN	W.L	20 PIN	CHIP
TA	AT 25°C	SMALL OUTLINE (D008)	CERAMIC DIP (JG)	PLASTIC DIP (P)	SMALL OUTLINE (D014)	CERAMIC DIP (J)	PLASTIC DIP (N)	CHIP CARRIER (FK)	FORM (Y)
0°C to 70°C	1 μV 3 μV	TLC2652AC-8D TLC2652C-8D		TLC2652ACP TLC2652CP	TLC2652AC-14D TLC2652C-14D		TLC2652ACN TLC2652CN	Y.COM.T	TLC2652Y
-40°C to 85°C	1 μV 3 μV	TLC2652AI-8D TLC2652A-8D	- N	TLC2652AIP TLC2652IP	TLC2652AI-14D TLC2652I-14D	- W -	TLC2652AIN TLC2652IN	MO J.V	TW
-40°C to 125°C	3.5 μV	TLC2652Q-8D	_WT.	WWW.	100X COM	TW	WWW.	100 <u>7</u> .CO	M.TW
−55°C to 125°C	3 μV 3.5 μV	TLC2652AM-8D TLC2652M-8D	TLC2652AMJG TLC2652MJG	TLC2652AMP TLC2652MP	TLC2652AM-14D TLC2652M-14D	TLC2652AMJ TLC2652MJ	TLC2652AMN TLC2652MN	TLC2652AMFK TLC2652MFK	OML.

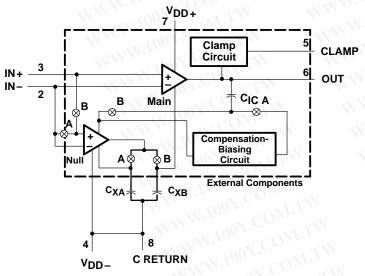
AVAILABLE OPTIONS

The D008 and D014 packages are available taped and reeled. Add R suffix to the device type (e.g., TLC2652AC-8DR). Chips are tested at 25°C.

RUMENTS

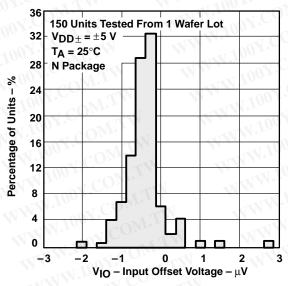
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functional block diagram



Pin numbers shown are for the D (14 pin), JG, and N packages.

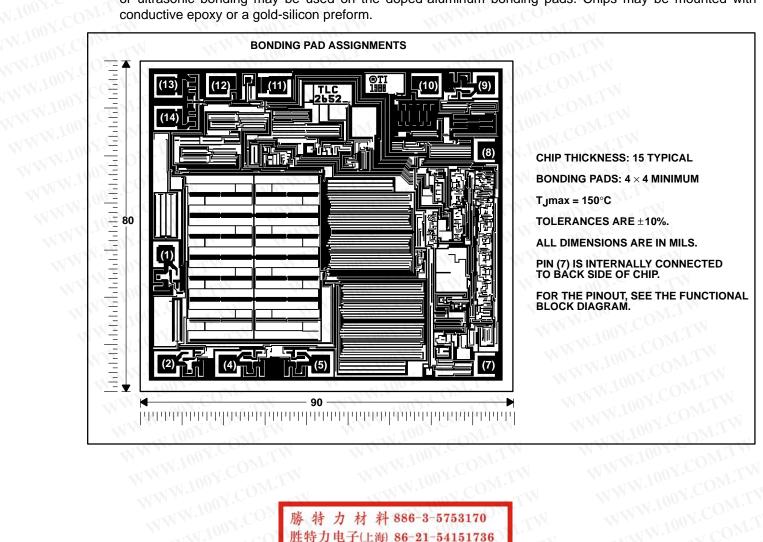
DISTRIBUTION OF TLC2652 INPUT OFFSET VOLTAGE



TLC2652, TLC2652A, TLC2652Y Advanced LinCMOS[™] PRECISION CHOPPER-STABILIZED OPERATIONAL AMPLIFIERS SLOS019D – SEPTEMBER 1988 – REVISED APRIL 2001

TLC2652Y chip information

This chip, when properly assembled, displays characteristics similar to the TLC2652C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage V _{DD+} (see Note 1)	
Supply voltage V _{DD} (see Note 1)	8 V
Differential input voltage, VID (see Note 2)	
Input voltage, V _I (any input, see Note 1)	
Voltage range on CLK IN and INT/EXT	
Input current, I _I (each input)	±5 mA
Output current, I _O	
Duration of short-circuit current at (or below) 25 °C (see Note 3) .	unlimited
Current into CLK IN and INT/EXT	
Continuous total dissipation	
Operating free-air temperature range, T _A : C suffix	
l suffix	−40°C to 85°C
Q suffix	–40°C to 125°C
Storage temperature range	
Case temperature for 60 seconds: FK package	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D	
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between VDD+ and VDD-.

2. Differential voltages are at IN+ with respect to IN-.

3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D008	725 mV	5.8 mW/°C	464 mW	377 mW	145 mW
D014	950 mV	7.6 mW/°C	608 mW	494 mW	190 mW
FK	1375 mV	11.0 mW/°C	880 mW	715 mW	275 mW
J	1375 mV	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mV	8.4 mW/°C	672 mW	546 mW	210 mW
N	1575 mV	12.6 mW/°C	1008 mW	819 mW	315 mW
P	1000 mV	8.0 mW/°C	640 mW	520 mW	200 mW

recommended operating conditions

	C	SUFFIX	19	SUFFIX	Q	SUFFIX	M	SUFFIX	UNIT
WW	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Supply voltage, V _{DD±}	±1.9	±8	±1.9	±8	±1.9	±8	±1.9	±8	V
Common-mode input voltage, VIC	V _{DD} -	V _{DD+} -1.9	V						
Clock input voltage	V _{DD} -	V _{DD-} +5	V _{DD} -	V _{DD-} +5	V _{DD} -	V _{DD} _+5	V _{DD} -	V _{DD-} +5	V
Operating free-air temperature, TA	0	70	-40	85	-40	125	-55	125	°C



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WT	MM 100Y		101to_10	Т	LC2652	С	TL	_C2652A	NC	
	PARAMETER	TEST CONDITIONS	TAT	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
<u>V.</u> r.,	1.100 Martin 1.100	CONT	25°C	~1	0.6	3		0.5	1	v
VIO	Input offset voltage	TW	Full range	100 x.	(0)	4.35	-1		2.35	μV
αΛΙΟ	Temperature coefficient of input offset voltage	N.COM.TW	Full range	.1002	0.003	0.03	Z	0.003	0.03	μV/°C
MO	Input offset voltage long-term drift (see Note 4)	V _{IC} = 0, R _S = 50 Ω	25°C	N.10	0.003	0.06	W	0.003	0.02	μV/m
CON	Input offset current	N.COMP.TW	25°C	NY	2	60	WT.	2	60	pА
10	input onset current	.100 COM. L	Full range	NN.		100			100	рА
lun.	Input bias current	N.1001.COM.TV	25°C		4	60	1.1	4	60	pА
IB	Input bias current	TION. CONTRACTO	Full range		x1 100	100	T.M.		100	рА
VICR	Common-mode input voltage range	R _S = 50 Ω	Full range	-5 to 3.1	W.10	0X.C	-5 to 3.1	LM LM		V
	Maximum positive peak	D 40 kg Cra Nata /	25°C	4.7	4.8	. No	4.7	4.8		v
VOM+	output voltage swing	$R_L = 10 k\Omega$, See Note 5	Full range	4.7	WW.	10-	4.7	Nr.	X	v
01.10	Maximum negative peak	$R_{I} = 10 k\Omega$, See Note 5	25°C	-4.7	-4.9	1.100	-4.7	-4.9		v
VOM-	output voltage swing	$K_{L} = 10 \text{ ksz}, \text{See Note s}$	Full range	-4.7	N.	×110	-4.7	M.		v
AVD	Large-signal differential	$V_{O} = \pm 4 V$, $R_{I} = 10 k\Omega$	25°C	120	150	N	135	150	WT.	dB
, vD	voltage amplification	$V_0 = \pm 1.0$, $U_1 = 10$ M	Full range	120		M.r	130	COM	In	u D
fch	Internal chopping frequency	W . 100 r.	25°C		450	WI.	00 -	450	1. ¹	Hz
	Clamp on-state current	R _I = 100 kΩ	25°C	25	N		25		M.T.	μA
WIR	Clamp on state current	NL = 100 K32	Full range	25	1	NN V	25	N.C		μΛ
	Clamp off-state current	$V_{O} = -4 V \text{ to } 4 V$	25°C	A.		100	N.1.	N.C	100	pА
N.	Clamp on state current	VU = + V KO + V	Full range			100	V.1	JU =	100	р/ т
CMRR	Common-mode rejection	$V_{O} = 0$, $V_{IC} = V_{ICR}min$,	25°C	120	140	N.	120	140		dB
	ratio	R _S = 50 Ω	Full range	120		V	120	1001	.00-	GD
KSVR	Supply-voltage rejection ratio	$V_{DD\pm} = \pm 1.9 V \text{ to } \pm 8 V,$	25°C	110	135	-	110	135	V.CO	dB
NOVK	$(\Delta V_{DD\pm}/\Delta V_{IO})$	$V_{O} = 0,$ $R_{S} = 50 \Omega$	2 Full range	110			110	N.100	10	uD
IDD	Supply current	IN NN	25°C	I.M.	1.5	2.4		1.5	2.4	mA
עטי	Supply Sulferit	WW WW	Full range	J		2.5	WW		2.5	

electrical characteristics at specified free-air temperature, $V_{DD} \pm = \pm 5 V$ (unless otherwise noted)

[†] Full range is 0° to 70°C.

NOTES: 4. Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}$ C extrapolated at $T_A = 25^{\circ}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

5. Output clamp is not connected.

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operating characteristics specified free-air temperature, $V_{DD+} = \pm 5 V$

	DADAMETED	TEST	- +	TI	_C26520		TL	C2652A	С	
	PARAMETER	CONDITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
SR+	Desitive alow rate at unity gain	CON.	25°C	2	2.8	COM	2	2.8		1////
SK+	Positive slew rate at unity gain	$V_0 = \pm 2.3 V,$	Full range	1.5	100 1.	100	1.5			V/μs
SR-	Negative slew rate at unity gain	$R_L = 10 k\Omega,$ C _L = 100 pF	25°C	2.3	3.1		2.3	3.1		V/µs
SK-	Negative slew rate at unity gain	N.COM	Full range	1.8	100	1.00	1.8	N		v/μs
v - CC	Equivalent input noise voltage	f = 10 Hz	25°C	WIT	94	J.C	Dir.	94	140	
Vn	(see Note 6)	f = 1 kHz	25°C		23		O _{<i>M</i>} .,	23	35	nV/√Hz
v.0.2	Peak-to-peak equivalent input	f = 0 to 1 Hz	25°C	N.	0.8	001.	Mo	0.8		
VN(PP)	noise voltage	f = 0 to 10 Hz	25°C	Z	2.8	Yoo.	COL	2.8		μV
In	Equivalent input noise current	f = 10 kHz	25°C	2	0.004	.1.		0.004		fA/√Hz
N.100 X	Gain-bandwidth product	f = 10 kHz, R _L = 10 kΩ, C _L = 100 pF	25°C		1.9	N.100	N.CO	1.9	N	MHz
φ m (19	Phase margin at unity gain	R _L = 10 kΩ, C _L = 100 pF	25°C		48°	NW.1	00Y.C	48°	WT	

[†] Full range is 0° to 70°C.

NOTE 6: This parameter is tested on a sample basis for the TLC2652A. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

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WT	YOU TOOY			1.×00	LC2652	T.V.	Т	LC2652A	1	
	PARAMETER	TEST CONDITIONS	TA [†]	MIN	ТҮР	MAX	MIN	TYP	MAX	UNIT
	land affect welters W.100	COMPT	25°C	100	0.6	3	I	0.5	1	
VIO	Input offset voltage	N.CONLTN	Full range	N.100	- c0	4.95	- 1		2.95	μV
αΛΙΟ	Temperature coefficient of input offset voltage	OY.COM.TW	Full range	W.10	0.003	0.03		0.003	0.03	μV/°C
COM	Input offset voltage long-term drift (see Note 4)	$V_{IC} = 0,$ $R_S = 50 \Omega$	25°C	NN.I	0.003	0.06	WT	0.003	0.02	μV/m
CON	Input offect ourrent	TWONY.CONT.	25°C 🔬	WAL.	2	60	NT.	2	60	54
10	Input offset current	N.100 COM. I	Full range	WW	.10-	150	NI-	N	150	рA
	Input bias current	N.1001.COM.TV	25°C		4	60	W.r	4	60	pА
IB C	Input bias current	100Y.COMT	Full range	A.v.	10	150	M		150	рА
VICR	Common-mode input voltage range	R _S = 50 Ω	Full range	-5 to 3.1		100X.C	-5 to 3.1			V
	Maximum positive peak	D. 10 kO See Note 5	25°C	4.7	4.8		4.7	4.8		v
VOM+	output voltage swing	$R_{L} = 10 \text{ k}\Omega$, See Note 5	Full range	4.7	W	1.102	4.7	Wr.	N	v
va.10	Maximum negative peak	$R_{I} = 10 k\Omega$, See Note 5	25°C	-4.7	-4.9	W.10	-4.7	-4.9	-1	v
VOM-	output voltage swing	$K_{L} = 10 \text{ ksz}, \text{ See Note 5}$	Full range	-4.7	A.M.	-11	-4.7	M	L VI	v
AVD	Large-signal differential	$V_{O} = \pm 4 V$, $R_{L} = 10 k\Omega$	25°C	120	150	1 11.	135	150	WT	dB
ΛVD	voltage amplification	$v_0 = \pm 4 v, N_1 = 10 N_{22}$	Full range	120	- 1	WW.	125	COM	II	üD
	Internal chopping frequency	W	25°C		450	W	.100 *	450	V. r. ,	Hz
	Clamp on-state current	R _L = 100 kΩ	25°C	25		N 11	25	y.~	M.T.	μA
WIE	oramp on state ourrent		Full range	25		NN	25	N.C		μ
	Clamp off-state current	$V_{O} = -4 V \text{ to } 4 V$	25°C			100	N.10	N.C	100	рА
11.		10 110 11	Full range	1. L. Y	1	100	NN.		100	pr.
CMRR	Common-mode rejection	$V_{O} = 0$, $V_{IC} = V_{ICR}min$,	25°C	120	140	N.	120	140	-01	dB
-	ratio	R _S = 50 Ω	Full range	120	N	V	120	1001		AT.
ksvr	Supply-voltage rejection	$V_{DD\pm} = \pm 1.9 V$ to $\pm 8 V$,	25°C	110	135		110	135	y.CU	dB
OWN	ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{O} = 0, \qquad R_{S} = 50 \ \Omega$	Full range	110			110	1.100	-1 C	DMr.,
IDD	Supply current	$V_{O} = 0$, No load	25°C	Mos	1.5	2.4	NN .	1.5	2.4	mA
	NIN N. ON	WW WW	Full range		WT.	2.5		1	2.5	

electrical characteristics at specified free-air temperature, $V_{DD} \pm = \pm 5 V$ (unless otherwise noted)

[†] Full range is -40° to 85° C.

NOTES: 4. Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}$ C extrapolated at $T_A = 25^{\circ}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

5. Output clamp is not connected.



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operating characteristics at specified free-air temperature, $V_{DD+} = \pm 5 V$

	PADAMETED 1001	TEST	-4	10	LC2652	1.100	TL	C2652A	1	
	PARAMETER	CONDITIONS	τ _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
en.M.	Desitive alow rate at unity gain	CONL	25°C	2	2.8	COM	2	2.8		Mus
SR+	Positive slew rate at unity gain	$V_0 = \pm 2.3 V$,	Full range	1.4	100 1.	102	1.4			V/μs
SR-	Negative alow rate at unity gain	$R_L = 10 k\Omega,$ C _L = 100 pF	25°C	2.3	3.1		2.3	3.1		V/uo
SK-	Negative slew rate at unity gain	N.COMP	Full range	1.7	100	1.00	1.7	N		V/μs
v - CC	Equivalent input noise voltage	f = 10 Hz	25°C	WIT	94	J.C)Mr	94	140	
Vn	(see Note 6)	f = 1 kHz	25°C		23		0 _W .,	23	35	nV/√Hz
. Coo	Peak-to-peak equivalent input	f = 0 to 1 Hz	25°C	AL A	0.8	001.2	Mo	0.8		
VN(PP)	noise voltage	f = 0 to 10 Hz	25°C	V	2.8	Ynn		2.8		μV
In	Equivalent input noise current	f = 1 kHz	25°C	-	0.004	.1		0.004	I	pA/√Hz
N.100X	Gain-bandwidth product	f = 10 kHz, R _L = 10 kΩ, C _L = 100 pF	25°C		1.9	W.100	X.CO	1.9	N	MHz
φm	Phase margin at unity gain	R _L = 10 kΩ, C _L = 100 pF	25°C		48°	NW.1	00X.C	48°	WT	

[†] Full range is -40° to 85°C.

NOTE 6: This parameter is tested on a sample basis for the TLC2652A. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

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TW	PARAMETER	TEST CONDITIONS	TAT		LC26520 LC26521		TL	.C2652A	М	UNIT
V.T.V	W 1.100	CONLIN	W	MIN	TYP	MAX	MIN	TYP	MAX	
VIO	Input offset voltage	Y.C. TW	25°C	a 100'	0.6	3.5		0.5	3	μV
۷IO	(see Note 7)	NT.COMTW	Full range	10	N.CC	10			8	μv
ανιο	Temperature coefficient of input offset voltage	LOOX.COM.TW	Full range		0.003	0.03*		0.003	0.03*	μV/°C
coN	Input offset voltage long-term drift (see Note 4)	$V_{IC} = 0$, $R_S = 50 \Omega$	25°C	WW.	0.003	0.06*	TW.	0.003	0.02*	μV/mo
had	Input offset current	N.1001. COM.TV	25°C	VIA	2	60	1.1	2	60	рА
10	Input onset current	TI 100Y.COM.TW	Full range		N.100	500	MIT		500	рА
. Z.C	Input bias current	W. ANY.COM T	25°C	AM.	4	60	- 11	4	60	рA
IВ	Input bias current	NW.ION COM.	Full range	W	W.,	500	Un-	Wn	500	рА
VICR	Common-mode input voltage range	R _S = 50 Ω	Full range	-5 to 3.1	UWW.	100X	-5 to 3.1	I.TW	Ţ	v
100	Maximum positive peak	1002.00	25°C	4.7	4.8	1.100	4.7	4.8	-1	
VOM+	output voltage swing	$R_L = 10 k\Omega$, See Note 5	Full range	4.7	M.M.	100	4.7	T.M.	~	V
<u> </u>	Maximum negative peak		25°C	-4.7	-4.9		-4.7	-4.9	N I	.,
VOM-	output voltage swing	$R_L = 10 k\Omega$, See Note 5	Full range	-4.7	- AL	NN.	-4.7	OM.	W	V
A	Large-signal differential		25°C	120	150	WIN.	135	150		- ID
AVD	voltage amplification	$V_{O} = \pm 4 V$, $R_{L} = 10 k\Omega$	Full range	120	N		120		V.I.A.	dB
fch	Internal chopping frequency	YOO WW	25°C	N	450		1100	450	TIM	Hz
	Clamp on-state current	$V_{O} = -5 V$ to 5 V	25°C	25		WW	25	N.CC		μA
M.	Clamp on-state current	$v_0 = -3 v_{10} 3 v_0$	Full range	25		-15	25	-1 C	О _И .,	μA
MN	Clamp off-state current	R _I = 100 kΩ	25°C	1.11		100		001	100	рA
	Clamp on-State current	NL = 100 K32	Full range	VT.		500		1001.	500	РЛ
CMRR	Common-mode rejection	$V_{O} = 0$, $V_{IC} = V_{ICR}min$,	25°C	120	140	1	120	140	COr	dB
	ratio	R _S = 50 Ω	Full range	120	- 1	4	120	1.100		, ab
ksvr	Supply-voltage rejection	$V_{DD\pm} = \pm 1.9 \text{ V to } \pm 8 \text{ V},$	25°C	110	135		110	135		dB
	ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{O} = 0$, $R_{S} = 50 \Omega$	Full range	110	WT		110	11	01.0	
IDD	Supply current	V _O = 0, No load	25°C	COn	1.5	2.4	W	1.5	2.4	mA
.00	espery content	. U = 0, 100 1000	Full range			2.5			2.5	C02

electrical characteristics at specified free-air temperature, $V_{DD} \pm = \pm 5 V$ (unless otherwise noted)

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

[†] Full range is -40° to 125°C for Q suffix, -55° to 125°C for M suffix.

NOTES: 4. Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated at $T_A = 25^{\circ}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

5. Output clamp is not connected.

 This parameter is not production tested. Thermocouple effects preclude measurement of the actual V_{IO} of these devices in high speed automated testing. V_{IO} is measured to a limit determined by the test equipment capability at the temperature extremes. The test ensures that the stabilization circuitry is performing properly.



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operating characteristics specified free-air temperature, $V_{DD+} = \pm 5 V$

SR+ Positive slew rate at unit SR- Negative slew rate at un V _n Equivalent input noise ve	WW.100Y.COM	$V_{O} = \pm 2.3 V,$ R _L = 10 kΩ, C _L = 100 pF	25°C Full range 25°C	MIN 2 1.3	TYP MAX 2.8	· V/μs
SR – Negative slew rate at un	WW.100Y.COM	$R_{L} = 10 \text{ k}\Omega,$	Full range	1.3	2.8	V/µs
SR – Negative slew rate at un	WW.100Y.COM	$R_{L} = 10 \text{ k}\Omega,$			1	v/µs
N.COM.TW Y	ty gain		25°C	0.0		1
N.COM.TW Y		WW WW		2.3	3.1	\//uo
V _n Equivalent input noise vo	10. W. CO		Full range	1.6		V/μs
equivalent input noise vo		f = 10 Hz	25°C	One	94	
	bitage	f = 1 kHz	25°C	CO _M .	23	nV/√Hz
	WW 1001.0	f = 0 to 1 Hz	25°C	Mo	0.8	
VN(PP) Peak-to-peak equivalent	input noise voitage	f = 0 to 10 Hz	25°C	1.00	2.8	μV
In Equivalent input noise cu	irrent	f = 1 kHz	25°C	V.CO	0.004	pA/√Hz
Gain-bandwidth product	WWW.100	f = 10 kHz, R _L = 10 kΩ, C _L = 100 pF	25°C	10Y.CC	1.9	MHz
φ _m Phase margin at unity ga	in www.10	R _L = 10 kΩ, C _L = 100 pF	25°C	1007.	48°	

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electrical characteristics at V_{DD\pm} = \pm 5 V, T_A = 25°C (unless otherwise noted)

WT	DADAMETED	trior of		T	LC2652	Y	
	PARAMETER	TEST C	ONDITIONS	MIN	TYP	MAX	UNIT
VIO	Input offset voltage	WW.IO	CONT.	J	0.6	3	μV
TIM	Input offset voltage long-term drift (see Note 4)	N	D- 500		0.003	0.006	μV/mo
lio	Input offset current	$V_{IC} = 0,$	R _S = 50 Ω		2	60	pА
IIB	Input bias current	WWW.	LOON.COMP	W	4	60	pА
VICR	Common-mode input voltage range	R _S = 50 Ω	N.100X.COM	-5 to 3.1			V
VOM+	Maximum positive peak output voltage swing	$R_L = 10 k\Omega$,	See Note 5	4.7	4.8		V
VOM-	Maximum negative peak output voltage swing	$R_L = 10 k\Omega$,	See Note 5	-4.7	-4.9		V
AVD	Large-signal differential voltage amplification	$V_0 = \pm 4 V,$	$R_L = 10 k\Omega$	120	150		dB
fch	Internal chopping frequency	V Va	WWW. OOY.C	U.	450		Hz
00 .	Clamp on-state current	$R_L = 100 \text{ k}\Omega$	WW.IV	25	IN		μA
100%	Clamp off-state current	$V_0 = -4 V to$	4 V	CON		100	pА
CMRR	Common-mode rejection ratio	$V_{O} = 0,$ $R_{S} = 50 \Omega$	$V_{IC} = V_{ICR}min$,	120	140	N N	dB
ksvr	Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 1.9$ R _S = 50 Ω	V to ± 8 V, V _O = 0,	110	135	LM	dB
IDD	Supply current	V _O = 0,	No load	001.0	1.5	2.4	mA

NOTES: 4. Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}$ C extrapolated at $T_A = 25^{\circ}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

5. Output clamp is not connected.

operating characteristics at V_{DD±} = \pm 5 V, T_A = 25°C

NN	MAN AND ANY		TL	_C2652Y	100	
	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
SR+	Positive slew rate at unity gain	$V_{O} = \pm 2.3 V$, $R_{L} = 10 k\Omega$,	2	2.8	CO <i>N</i>	V/µs
SR- 🔨	Negative slew rate at unity gain	C _L = 100 pF	2.3	3.1		V/µs
v 🔨		f = 10 Hz	NN.	94		Sector-
Vn	Equivalent input noise voltage	f = 1 kHz	NW.	23	1.0	nV/√Hz
M	Peak to peak aquivalant input poins valtage	f = 0 to 1 Hz	- TN	0.8	~1(ON
V _{N(PP)}	Peak-to-peak equivalent input noise voltage	f = 0 to 10 Hz		2.8	140	μV
In	Equivalent input noise current	f = 1 kHz	N.	-11	001	pA/√Hz
	Gain-bandwidth product	$ f = 10 \text{ kHz}, \qquad R_{L} = 10 \text{ k}\Omega, \\ C_{L} = 100 \text{ pF} $	4	1.9	100	MHz
[¢] m	Phase margin at unity gain	$R_L = 10 \text{ k}\Omega$, $C_L = 100 \text{ pF}$		48°	U.10	1



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TYPICAL CHARACTERISTICS

Table of Graphs

	COMP. COMP.	- COMPANY COMPANY	FIGURE
VIO	Normalized input offset voltage	vs Chopping frequency	1
IIB	Input bias current	vs Common-mode input voltage vs Chopping frequency vs Free-air temperature	2 3 4
10	Input offset current	vs Chopping frequency vs Free-air temperature	5
T.Mo	Clamp current	vs Output voltage	7
V(OPP)	Maximum peak-to-peak output voltage	vs Frequency	8
VOM	Maximum peak output voltage	vs Output current vs Free-air temperature	9, 10 11, 12
AVD	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	13 14
oy.cc	Chopping frequency	vs Supply voltage vs Free-air temperature	15 16
IDD	Supply current	vs Supply voltage vs Free-air temperature	17 18
los	Short-circuit output current	vs Supply voltage vs Free-air temperature	19 20
SR	Slew rate	vs Supply voltage vs Free-air temperature	21 22
NN.10	Voltage-follower pulse response	Small-signal Large-signal	23 24
V _{N(PP)}	Peak-to-peak equivalent input noise voltage	vs Chopping frequency	25, 26
Vn	Equivalent input noise voltage	vs Frequency	27
WW	Gain-bandwidth product	vs Supply voltage vs Free-air temperature	28 29
[¢] m	Phase margin	vs Supply voltage vs Free-air temperature vs Load capacitance	30 31 32
	Phase shift	vs Frequency	13

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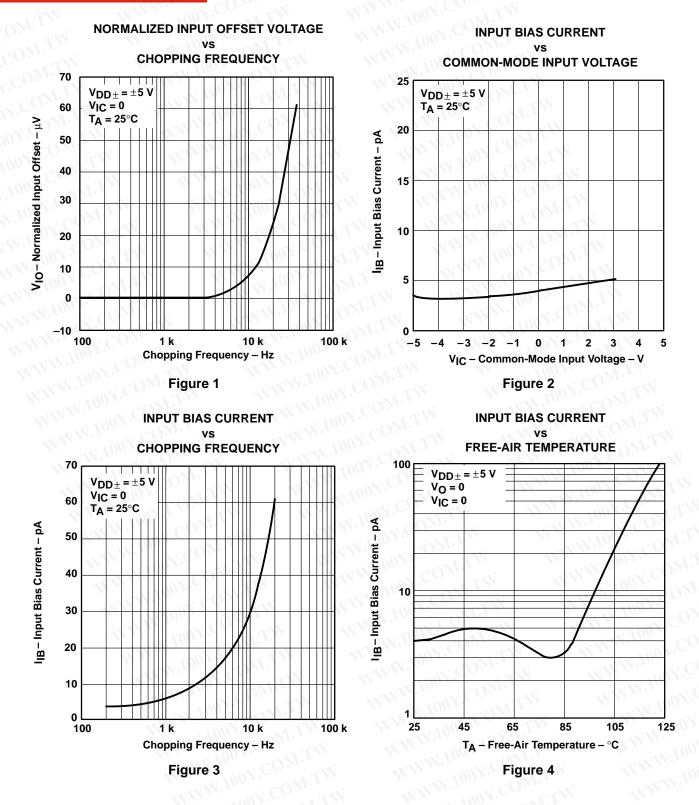


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TYPICAL CHARACTERISTICS[†]

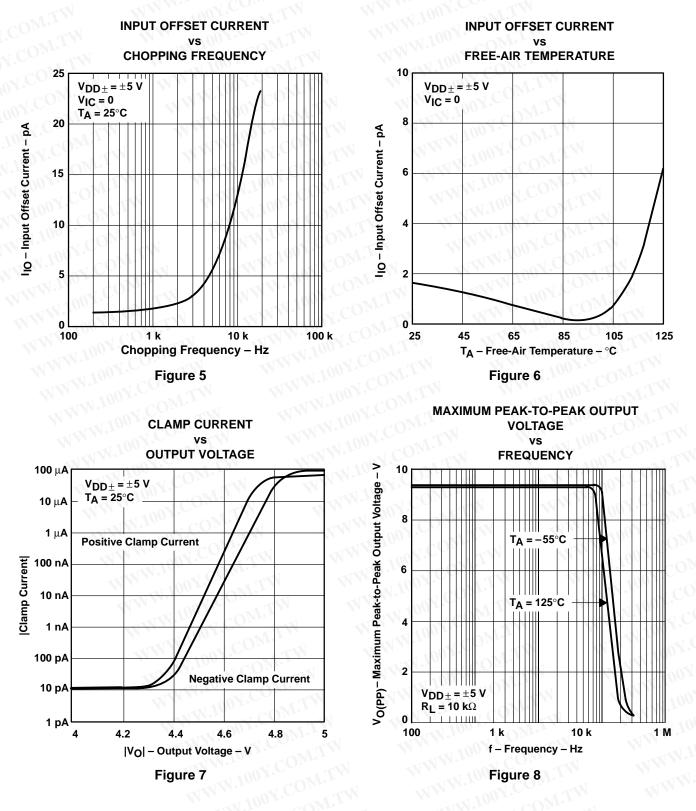


[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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TYPICAL CHARACTERISTICS[†]



[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

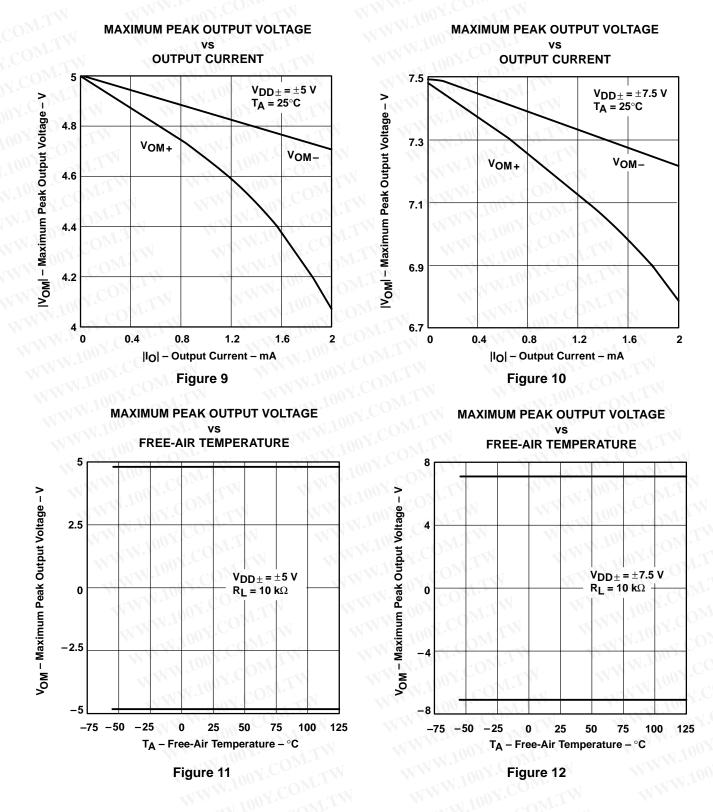


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TYPICAL CHARACTERISTICS[†]



[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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LARGE-SIGNAL DIFFERENTIAL VOLTAGE **AMPLIFICATION AND PHASE SHIFT** VS FREQUENCY 120 60° 100 **Phase Shift** 80° A_{VD}- Large-Signal Differential Voltage Amplification – dB 80 100° AVD 60 120° Shift 40 ase : 140° DOX.COM Ч 20 160° 0 180° $V_{DD\pm} = \pm 5 V$ $R_L = 10 k\Omega$ -20 200° $C_{L} = 100 \, pF$ T_A = 25°C -40 220° 100 10 k 10 1 k 100 k 1 M 10 M f - Frequency - Hz Figure 13 LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION VS **FREE-AIR TEMPERATURE** 155 $V_{DD\pm} = \pm 7.5 V$ $R_L = 10 k\Omega$ $V_0 = \pm 4 V$ Differential Voltage Amplification – dB 150 A_{VD}⁻ Large-Signal 145 勝特力材料 886-3-5753170 140 胜特力电子(上海) 86-21-54151736 胜特力电子(深圳) 86-755-83298787 Http://www. 100y. com. tw 135 -75 -50 -25 0 25 50 75 100 125 T_A – Free-Air Temperature – °C

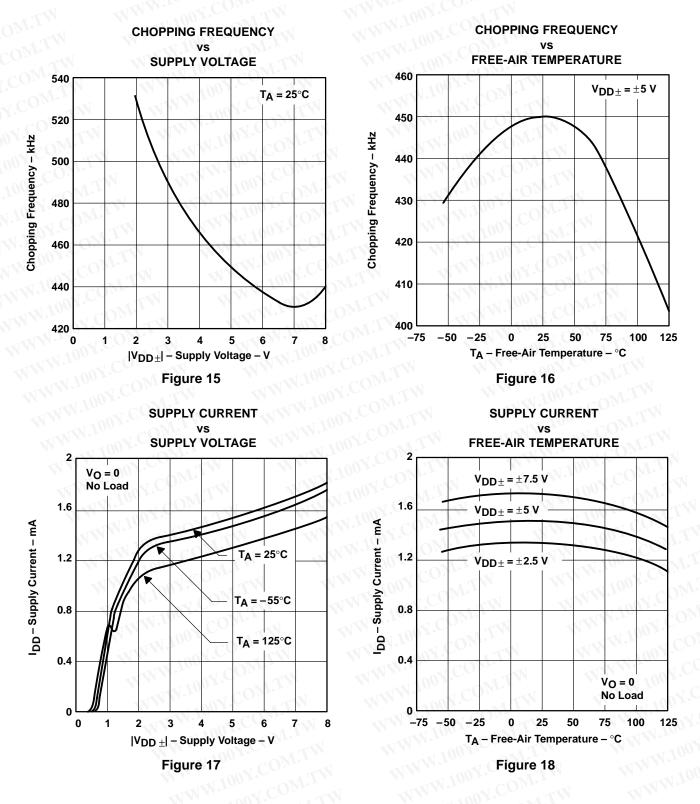
TYPICAL CHARACTERISTICS[†]

Figure 14

[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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TYPICAL CHARACTERISTICS[†]

[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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SHORT-CIRCUIT OUTPUT CURRENT SHORT-CIRCUIT OUTPUT CURRENT vs vs SUPPLY VOLTAGE FREE-AIR TEMPERATURE 12 15 $V_0 = 0$ $V_{DD\pm} = \pm 5 V$ T_A = 25°C $V_0 = 0$ Am-Short-Circuit Output Current – mA 8 10 IoS- Short-Circuit Output Current 4 5 $V_{ID} = -100 \text{ mV}$ $V_{ID} = -100 \text{ mV}$ 0 0 -4 -5 VID = 100 mV -SO -8 -10 V_{ID} = 100 mV -12 -150 1 2 3 4 5 6 7 8 -75 -50 -25 25 75 100 125 0 50 $|V_{DD \pm}|$ – Supply Voltage – V T_A – Free-Air Temperature – °C Figure 19 Figure 20 **SLEW RATE SLEW RATE** vs vs FREE-AIR TEMPERATURE SUPPLY VOLTAGE 4 $V_{DD\pm} = \pm 5 V$ $R_L = 10 \ k\Omega$ SR-SR CL = 100 pF 3 3 - V/µs SR – Slew Rate – V/µS SR+ SR+ Rate 2 2 SR - Slew 1 1 $R_L = 10 k\Omega$ $C_{L} = 100 \, pF$ T_A = 25°C 0 0 -75 -50 -25 0 25 50 75 0 1 2 3 4 5 6 7 100 125 $|V_{DD\pm}|$ – Supply Voltage – V TA – Free-Air Temperature – °C Figure 21 Figure 22

TYPICAL CHARACTERISTICS[†]

[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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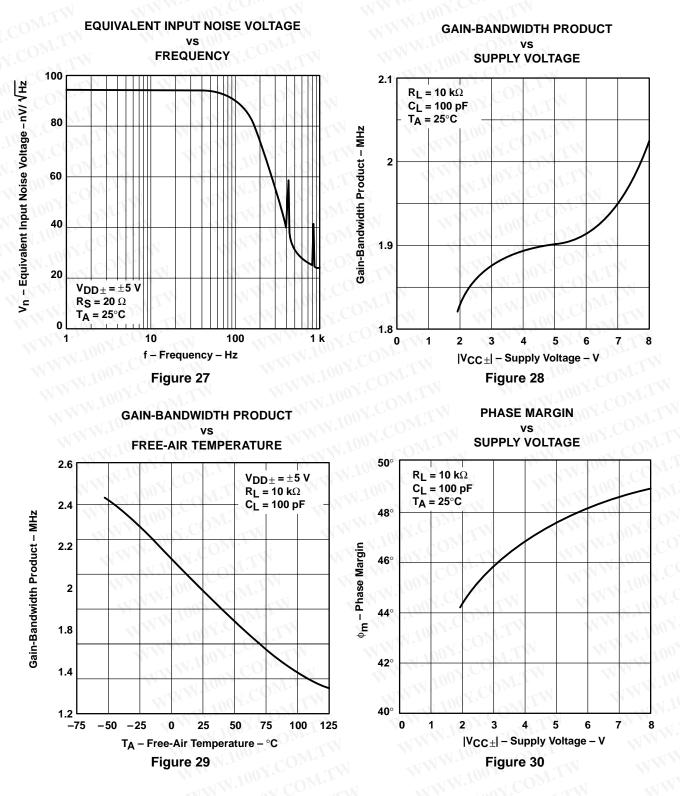
VOLTAGE-FOLLOWER VOLTAGE-FOLLOWER SMALL-SIGNAL LARGE-SIGNAL **PULSE RESPONSE** PULSE RESPONSE 100 $V_{DD\pm} = \pm 5 V$ $R_L = 10 k\Omega$ 3 75 $C_{L}^{-} = 100 \text{ pF}$ r T_A = 25°C 2 50 Р Г V_O - Output Voltage - V $V_{DD\pm} = \pm 5 V$ 25 1 **Output Voltage** $R_L = 10 k\Omega$ C_L = 100 pF 0 0 TA = 25°C -1 -25 آ م -50 -2 -75 -3 -100 -4 0 2 3 4 5 7 0 5 10 15 20 25 30 35 40 1 6 t – Time – µs t - Time - µs Figure 23 Figure 24 PEAK-TO-PEAK INPUT NOISE VOLTAGE PEAK-TO-PEAK INPUT NOISE VOLTAGE vs vs **CHOPPING FREQUENCY CHOPPING FREQUENCY** 1.8 5 VN(PP) – Peak-to-Peak Input Noise Voltage - μ V $VN(PP) - Peak-to-Peak Input Noise Voltage - <math>\mu V$ $V_{DD\pm} = \pm 5 V$ $V_{DD\pm} = \pm 5 V$ R_S = 20 Ω 1.6 Rs = 20 Ω f = 0 to 1 Hz f = 0 to 1 Hz 4 T_A = 25°C 1.4 T_A = 25°C 1.2 3 1 0.8 2 0.6 0.4 1 0.2 0 0 0 2 4 6 8 10 0 2 6 8 10 4 f_{ch} – Chopping Frequency – kHz fch – Chopping Frequency – kHz Figure 25 Figure 26

TYPICAL CHARACTERISTICS



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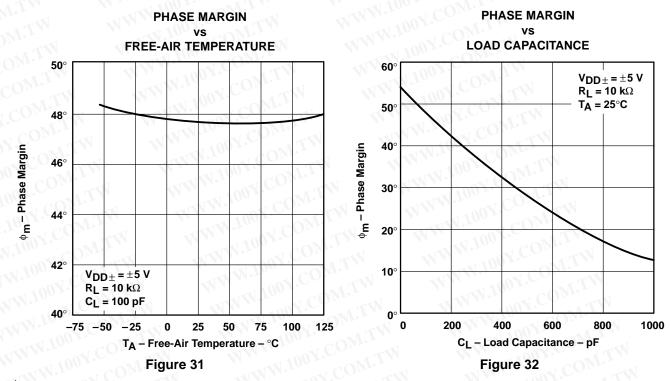


[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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TYPICAL CHARACTERISTICS[†]



[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

capacitor selection and placement

The two important factors to consider when selecting external capacitors C_{XA} and C_{XB} are leakage and dielectric absorption. Both factors can cause system degradation, negating the performance advantages realized by using the TLC2652.

Degradation from capacitor leakage becomes more apparent with the increasing temperatures. Low-leakage capacitors and standoffs are recommended for operation at $T_A = 125^{\circ}C$. In addition, guard bands are recommended around the capacitor connections on both sides of the printed circuit board to alleviate problems caused by surface leakage on circuit boards.

Capacitors with high dielectric absorption tend to take several seconds to settle upon application of power, which directly affects input offset voltage. In applications where fast settling of input offset voltage is needed, it is recommended that high-quality film capacitors, such as mylar, polystyrene, or polypropylene, be used. In other applications, however, a ceramic or other low-grade capacitor can suffice.

Unlike many choppers available today, the TLC2652 is designed to function with values of C_{XA} and C_{XB} in the range of 0.1 μ F to 1 μ F without degradation to input offset voltage or input noise voltage. These capacitors should be located as close as possible to the C_{XA} and C_{XB} pins and returned to either V_{DD-} or C RETURN. On many choppers, connecting these capacitors to V_{DD-} causes degradation in noise performance. This problem is eliminated on the TLC2652.



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APPLICATION INFORMATION

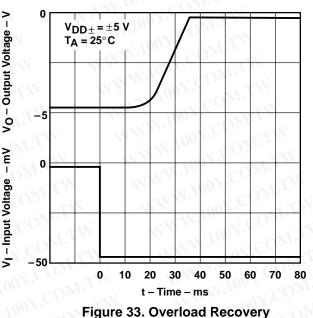
internal/external clock

The TLC2652 has an internal clock that sets the chopping frequency to a nominal value of 450 Hz. On 8-pin packages, the chopping frequency can only be controlled by the internal clock; however, on all 14-pin packages and the 20-pin FK package, the device chopping frequency can be set by the internal clock or controlled externally by use of the INT/EXT and CLK IN pins. To use the internal 450-Hz clock, no connection is necessary. If external clocking is desired, connect INT/EXT to V_{DD-} and the external clock to CLK IN. The external clock trip point is 2.5 V above the negative rail; however, CLK IN can be driven from the negative rail to 5 V above the negative rail. If this level is exceeded, damage could occur to the device unless the current into CLK IN is limited to ± 5 mA. When operating in the single-supply configuration, this feature allows the TLC2652 to be driven directly by 5-V TTL and CMOS logic. A divide-by-

two frequency divider interfaces with CLK IN and sets the clock chopping frequency. The duty cycle of the external clock is not critical but should be kept between 30% and 60%.

overload recovery/output clamp

When large differential input voltage conditions are applied to the TLC2652, the nulling loop attempts to prevent the output from saturating by driving C_{XA} and C_{XB} to internally-clamped voltage levels. Once the overdrive condition is removed, a period of time is required to allow the built-up charge to dissipate. This time period is defined as overload recovery time (see Figure 33). Typical overload recovery time for the TLC2652 is significantly faster than competitive products; however, if required, this time can be reduced further by use of internal clamp circuitry accessible through CLAMP if required.



The clamp is a switch that is automatically activated when the output is approximately 1 V from either supply rail. When connected to the inverting input (in parallel with the closed-loop feedback resistor), the closed-loop gain is reduced, and the TLC2652 output is prevented from going into saturation. Since the output must source or sink current through the switch (see Figure 7), the maximum output voltage swing is slightly reduced.

thermoelectric effects

To take advantage of the extremely low offset voltage drift of the TLC2652, care must be taken to compensate for the thermoelectric effects present when two dissimilar metals are brought into contact with each other (such as device leads being soldered to a printed circuit board). Dissimilar metal junctions can produce thermoelectric voltages in the range of several microvolts per degree Celsius (orders of magnitude greater than the 0.01- μ V/°C typical of the TLC2652).

To help minimize thermoelectric effects, careful attention should be paid to component selection and circuit-board layout. Avoid the use of nonsoldered connections (such as sockets, relays, switches, etc.) in the input signal path. Cancel thermoelectric effects by duplicating the number of components and junctions in each device input. The use of low-thermoelectric-coefficient components, such as wire-wound resistors, is also beneficial.

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RUMENTS

APPLICATION INFORMATION

latch-up avoidance

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC2652 inputs and output are designed to withstand – 100-mA surge currents without sustaining latch-up; however, techniques to reduce the chance of latch-up should be used whenever possible. Internal protection diodes should not, by design, be forward biased. Applied input and output voltages should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.

The current path established if latch-up occurs is usually between the supply rails and is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor. The chance of latch-up occurring increases with increasing temperature and supply voltage.

electrostatic discharge protection

The TLC2652 incorporates internal ESD-protection circuits that prevent functional failures at voltages at or below 2000 V. Care should be exercised in handling these devices, as exposure to ESD may result in degradation of the device parametric performance.

theory of operation

Chopper-stabilized operational amplifiers offer the best dc performance of any monolithic operational amplifier. This superior performance is the result of using two operational amplifiers, a main amplifier and a nulling amplifier, plus oscillator-controlled logic and two external capacitors to create a system that behaves as a single amplifier. With this approach, the TLC2652 achieves submicrovolt input offset voltage, submicrovolt noise voltage, and offset voltage variations with temperature in the nV/°C range.

The TLC2652 on-chip control logic produces two dominant clock phases: a nulling phase and an amplifying phase. The term chopper-stabilized derives from the process of switching between these two clock phases. Figure 34 shows a simplified block diagram of the TLC2652. Switches A and B are make-before-break types.

During the nulling phase, switch A is closed shorting the nulling amplifier inputs together and allowing the nulling amplifier to reduce its own input offset voltage by feeding its output signal back to an inverting input node. Simultaneously, external capacitor C_{XA} stores the nulling potential to allow the offset voltage of the amplifier to remain nulled during the amplifying phase.

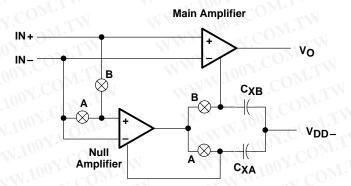


Figure 34. TLC2652 Simplified Block Diagram



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APPLICATION INFORMATION

theory of operation (continued)

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During the amplifying phase, switch B is closed connecting the output of the nulling amplifier to a noninverting input of the main amplifier. In this configuration, the input offset voltage of the main amplifier is nulled. Also, external capacitor C_{XB} stores the nulling potential to allow the offset voltage of the main amplifier to remain nulled during the next nulling phase.

This continuous chopping process allows offset voltage nulling during variations in time and temperature over the common-mode input voltage range and power supply range. In addition, because the low-frequency signal path is through both the null and main amplifiers, extremely high gain is achieved.

The low-frequency noise of a chopper amplifier depends on the magnitude of the component noise prior to chopping and the capability of the circuit to reduce this noise while chopping. The use of the Advanced LinCMOS process, with its low-noise analog MOS transistors and patent-pending input stage design, significantly reduces the input noise voltage.

The primary source of nonideal operation in chopper-stabilized amplifiers is error charge from the switches. As charge imbalance accumulates on critical nodes, input offset voltage can increase, especially with increasing chopping frequency. This problem has been significantly reduced in the TLC2652 by use of a patent-pending compensation circuit and the Advanced LinCMOS process.

The TLC2652 incorporates a feed-forward design that ensures continuous frequency response. Essentially, the gain magnitude of the nulling amplifier and compensation network crosses unity at the break frequency of the main amplifier. As a result, the high-frequency response of the system is the same as the frequency response of the main amplifier. This approach also ensures that the slewing characteristics remain the same during both the nulling and amplifying phases.

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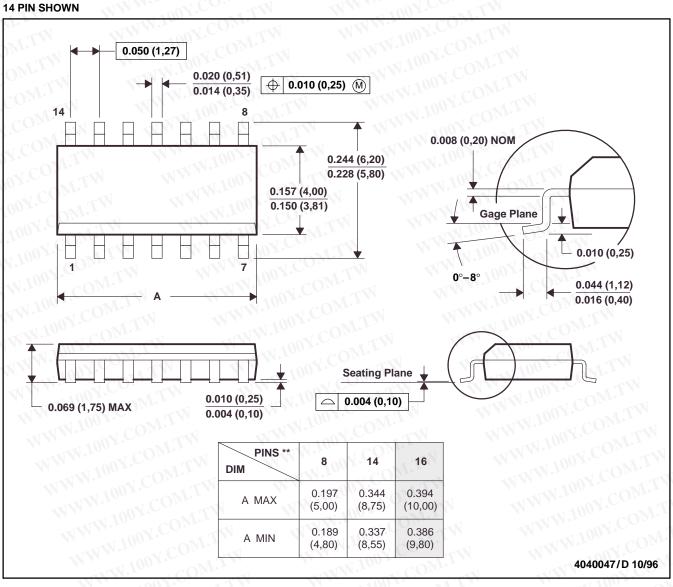


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MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

D (R-PDSO-G**)



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012



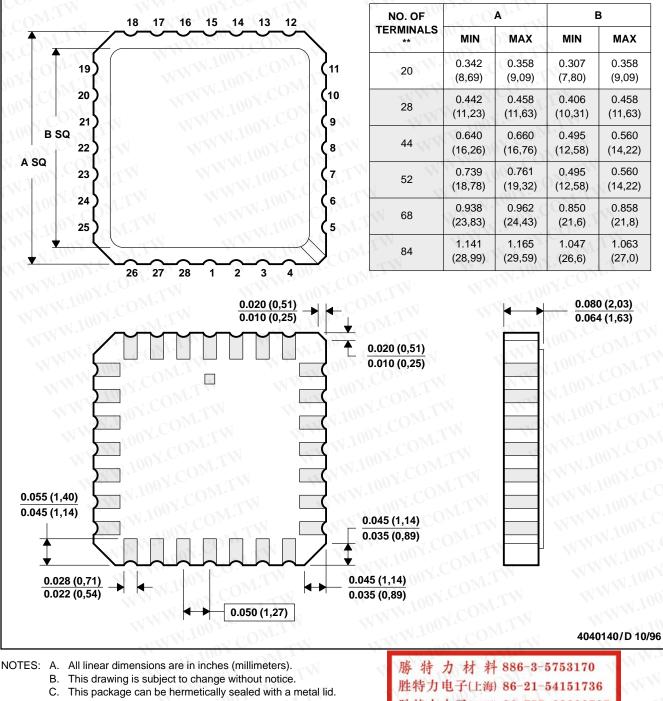
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MECHANICAL DATA

FK (S-CQCC-N**)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



D. The terminals are gold plated.E. Falls within JEDEC MS-004

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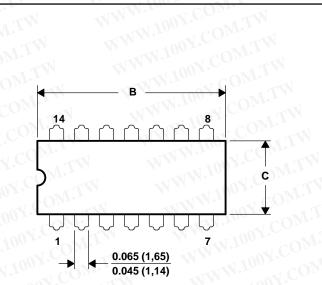


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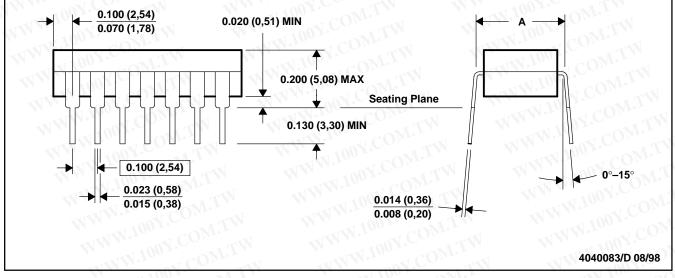
MECHANICAL DATA

CERAMIC DUAL-IN-LINE PACKAGE

J (R-GDIP-T**) 14 PIN SHOWN



PINS ** DIM	14	16	18	20
Α ΜΑΧ	0.310	0.310	0.310	0.310
	(7,87)	(7,87)	(7,87)	(7,87)
A MIN	0.290	0.290	0.290	0.290
	(7,37)	(7,37)	(7,37)	(7,37)
В МАХ	0.785	0.785	0.910	0.975
	(19,94)	(19,94)	(23,10)	(24,77)
B MIN	0.755	0.755	64 <u>7</u>	0.930
	(19,18)	(19,18)	64	(23,62)
C MAX	0.300	0.300	0.300	0.300
	(7,62)	(7,62)	(7,62)	(7,62)
C MIN	0.245	0.245	0.245	0.245
	(6,22)	(6,22)	(6,22)	(6,22)



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18, GDIP1-T20, and GDIP1-T22.



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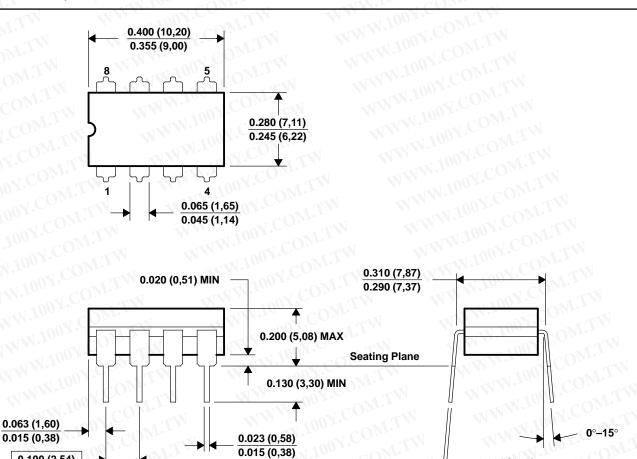
JG (R-GDIP-T8)

MECHANICAL DATA

CERAMIC DUAL-IN-LINE PACKAGE

0.014 (0,36) 0.008 (0,20)

4040107/C 08/96



NOTES: A. All linear dimensions are in inches (millimeters).

0.100 (2,54)

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- Index point is provided on cap for terminal identification on press ceramic glass frit seal only. D.
- E. Falls within MIL-STD-1835 GDIP1-T8

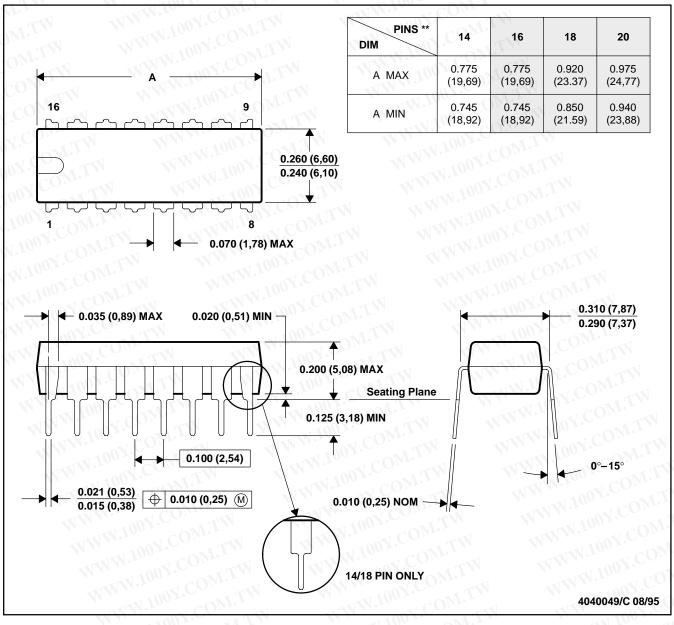


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MECHANICAL DATA

PLASTIC DUAL-IN-LINE PACKAGE



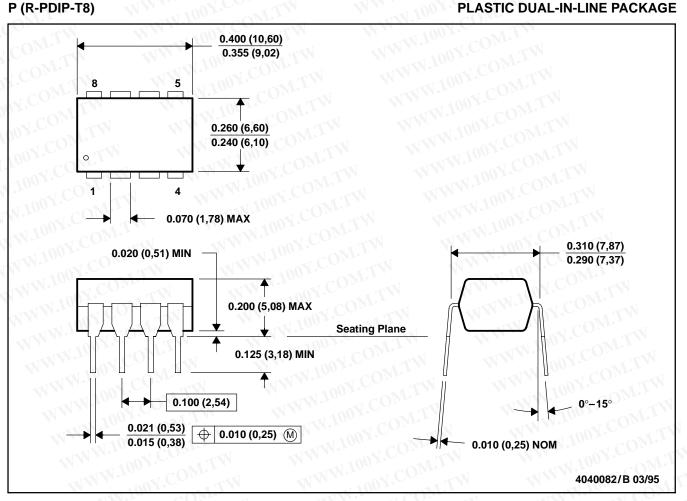


- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-001 (20 pin package is shorter then MS-001.)



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MECHANICAL DATA



- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-001



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